

PJQ55810A-AU

80V N-Channel Enhancement Mode MOSFET

Voltage

80 V

Current

60.5 A

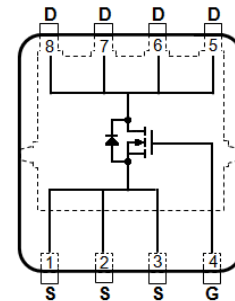
Features

- $R_{DS(ON)}$, $V_{GS}@10V$, $I_D@30A < 9.3m\Omega$
- $R_{DS(ON)}$, $V_{GS}@4.5V$, $I_D@15A < 12.7m\Omega$
- Excellent FOM
- Logic Level Drive
- AEC-Q101 qualified
- Lead free in compliance with EU RoHS 2.0
- Green molding compound as per IEC 61249 standard

Mechanical Data

- Case : DFN5060-8L Package
- Terminals : Solderable per MIL-STD-750, Method 2026
- Approx. Weight : 0.08 grams

DFN5060-8L



Maximum Ratings and Thermal Characteristics ($T_A=25^{\circ}C$ unless otherwise noted)

PARAMETER		SYMBOL	LIMIT	UNITS
Drain-Source Voltage		V_{DS}	80	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ^(Note 3)	$T_C=25^{\circ}C$	I_D	60.5	A
	$T_C=100^{\circ}C$		42.8	
Pulsed Drain Current ^(Note 1)	$T_C=25^{\circ}C$	I_{DM}	200	
Power Dissipation	$T_C=25^{\circ}C$	P_D	75.0	W
	$T_C=100^{\circ}C$		37.5	
Continuous Drain Current ^(Note 4)	$T_A=25^{\circ}C$	I_D	12.7	A
	$T_A=70^{\circ}C$		10.6	
Power Dissipation	$T_A=25^{\circ}C$	P_D	3.3	W
	$T_A=70^{\circ}C$		2.3	
Single Pulse Avalanche Current ^(Note 5)		I_{AS}	18.5	A
Single Pulse Avalanche Energy ^(Note 5)		E_{AS}	56.3	mJ
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55~175	$^{\circ}C$
Thermal Resistance ^(Note 4)	Junction to Case	$R_{\theta JC}$	2	$^{\circ}C/W$
	Junction to Ambient	$R_{\theta JA}$	45	

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Electrical Characteristics (T_A=25°C unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS
Static						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	80	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	1.1	1.8	2.3	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =30A	-	7.5	9.3	mΩ
		V _{GS} =4.5V, I _D =15A		9.8	12.7	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =80V, V _{GS} =0V	-	-	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Dynamic ^(Note 6)						
Total Gate Charge	Q _g	V _{DS} =40V, I _D =25A, V _{GS} =10V ^(Note 2)	-	17.5	23	nC
Gate-Source Charge	Q _{gs}		-	3.8	-	
Gate-Drain Charge	Q _{gd}		-	2.7	-	
Input Capacitance	C _{iss}	V _{DS} =40V, V _{GS} =0V, f=250kHz	-	980	1372	pF
Output Capacitance	C _{oss}		-	433	650	
Reverse Transfer Capacitance	C _{rss}		-	13	23	
Gate resistance	R _g	f=1MHz	-	1.4	2.8	Ω
Turn-On Delay Time	t _{d(on)}	V _{DS} =40V, I _D =25A, V _{GS} =10V, R _G =1.6Ω (Note 2)	-	5.1	-	ns
Turn-On Rise Time	t _r		-	2.4	-	
Turn-Off Delay Time	t _{d(off)}		-	13.9	-	
Turn-Off Fall Time	t _f		-	2.7	-	
Drain-Source Diode						
Diode Forward Current	I _S	T _C =25°C (Package Limit)	-	-	60.5	A
Pulsed Diode Forward Current	I _{SM}		-	-	200	
Diode Forward Voltage	V _{SD}	I _S =30A, V _{GS} =0V	-	0.9	1.2	V
Reverse Recovery Time	T _{rr}	V _{DD} =40V V _{GS} =0V,	-	42.8	-	ns
Reverse Recovery Charge	Q _{rr}	I _S =25A, dI _S /dt=100A/us	-	45.2	-	nC

NOTES :

- Pulse width≤100us, Duty cycle≤2%.
- Essentially independent of operating temperature typical characteristics.
- Chip capability with an R_{θJC}=2 °C/W.
- R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. Mounted on a 1 inch² with 2oz.square pad of copper.
- E_{AS} is calculated based on the condition of L=1mH, I_{AS}=10.6A, V_{DD}=30V, V_{GS}=10V. 100% test at L=0.1mH, I_{AS}=18.5A in production.
- Guaranteed by design, not subject to production testing.

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TYPICAL CHARACTERISTIC CURVES

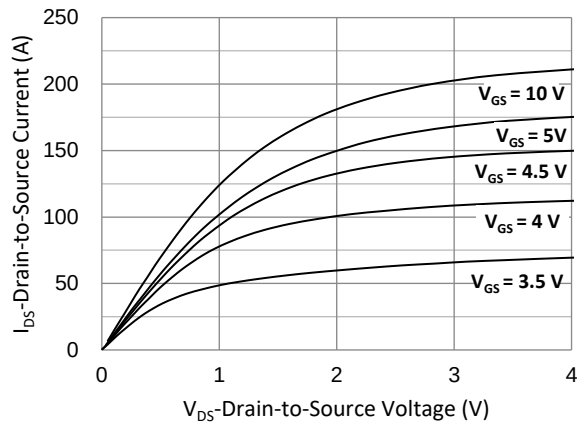


Fig.1 On-Region Characteristics

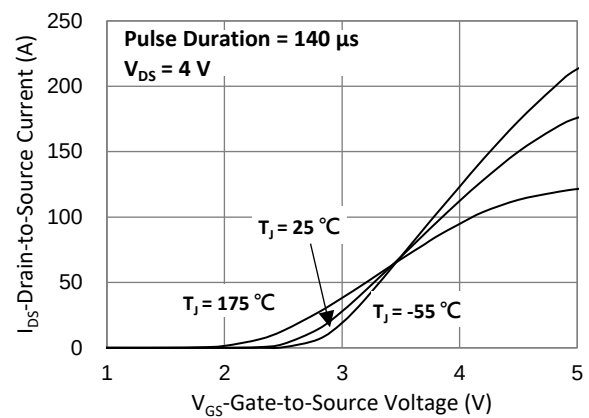


Fig.2 Transfer Characteristics

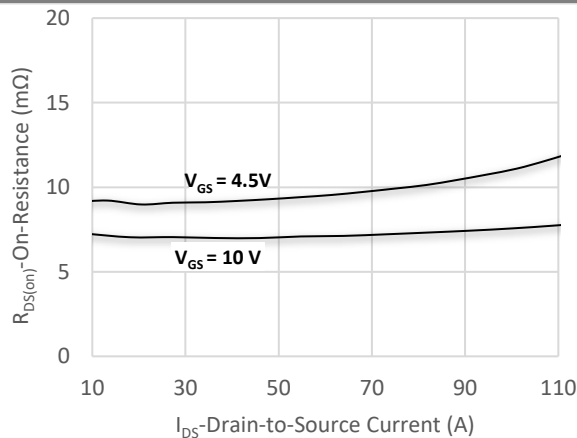


Fig.3 On-Resistance vs. Drain Current

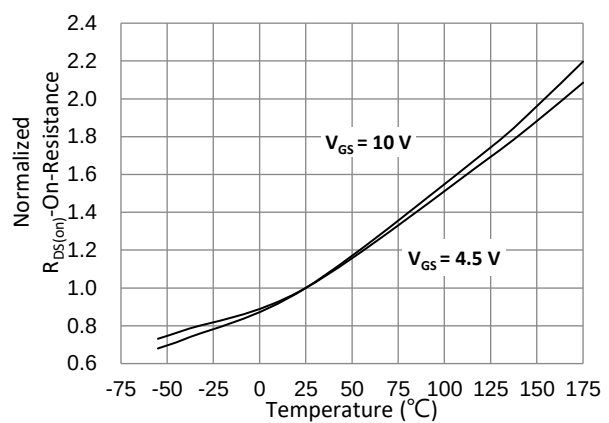


Fig.4 On-Resistance vs. Junction temperature

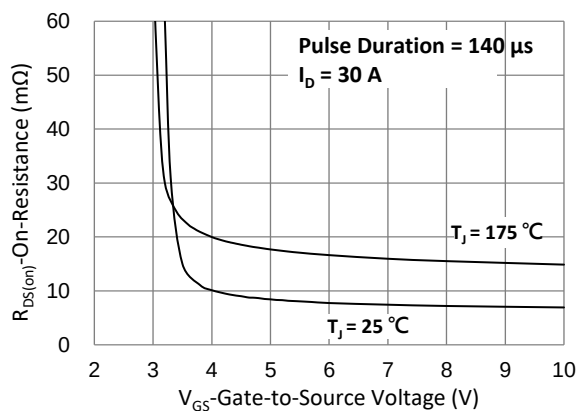


Fig.5 On-Resistance Variation with V_{GS}

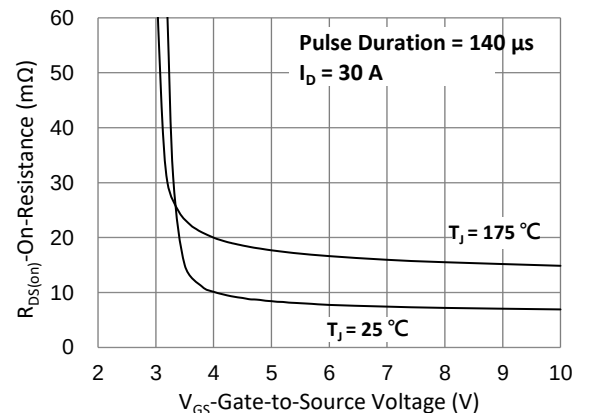


Fig.6 Source-Drain Diode Forward Voltage

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TYPICAL CHARACTERISTIC CURVES

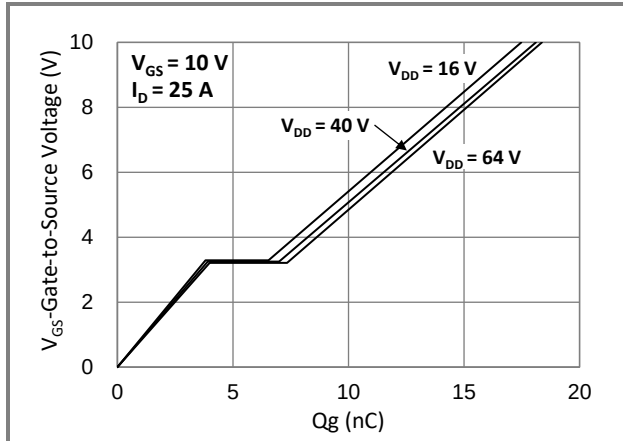


Fig.7 Gate-Charge Characteristics

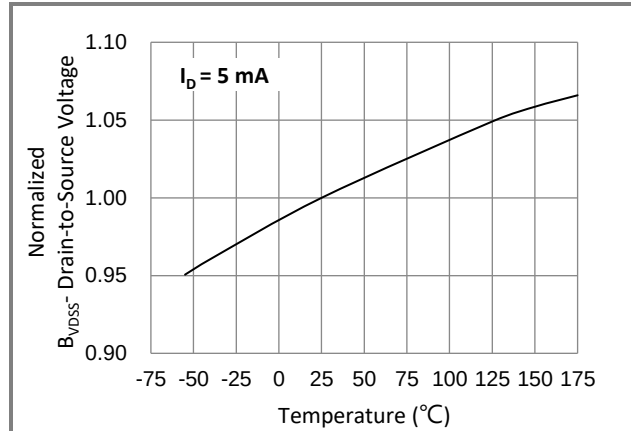


Fig.8 Breakdown Voltage Variation vs. Temperature

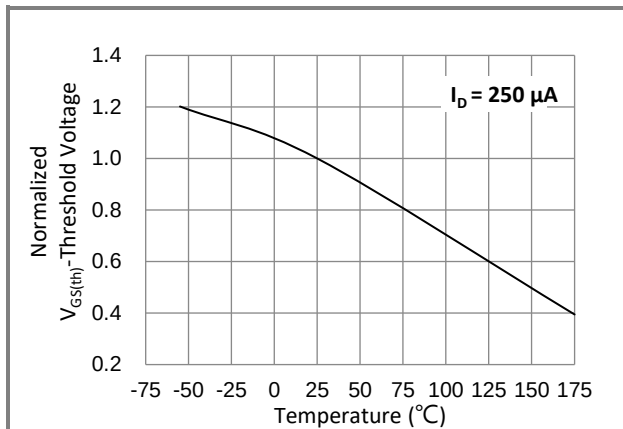


Fig.9 Threshold Voltage Variation with Temperature

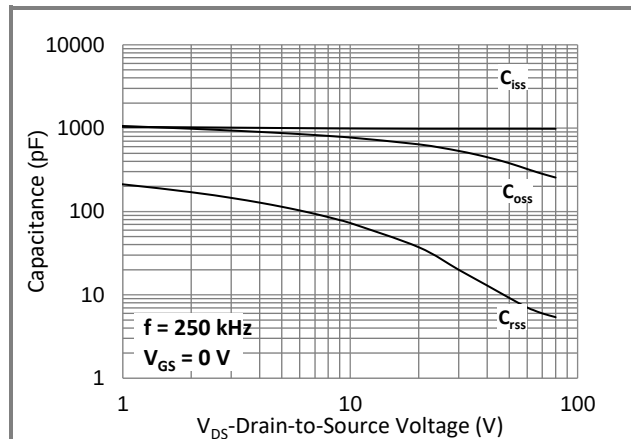


Fig.10 Capacitance vs. Drain-Source Voltage

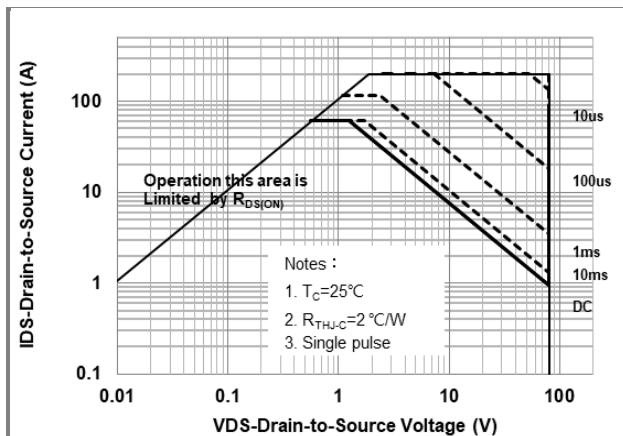


Fig.11 Maximum Safe Operating Area

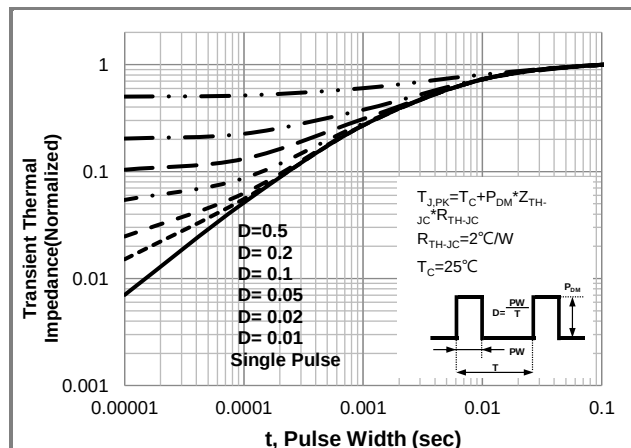


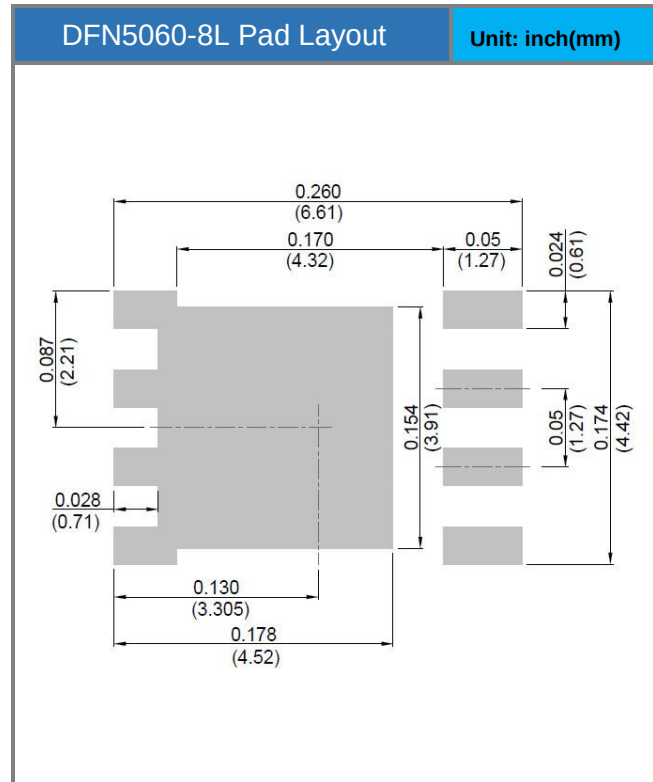
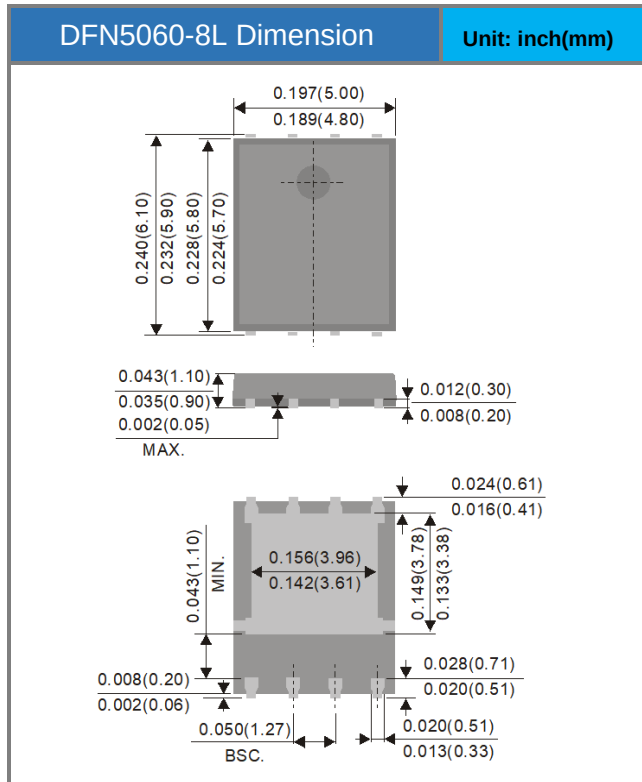
Fig.12 Normalized Transient Thermal Impedance

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Product and Packing Information

Part No.	Package Type	Packing Type	Marking
PJQ55810A-AU	DFN5060-8L	3K pcs / 13" reel	Q55810A

Packaging Information & Mounting Pad Layout



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